## Notice of References Cited

Application/Control No. 10/517,296	Reexaminati	Applicant(s)/Patent Under Reexamination HELLER, KLAUS		
Examiner	Art Unit	·		
SIMON D. NGUYEN	2618	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,219,340	04-2001	Cutler et al.	370/241
*	В	US-6,850,238	02-2005	Bryant et al.	345/440.1
*	С	US-6,519,227	02-2003	Koizumi, Satoshi	370/241
*	D	US-6,879,576	04-2005	Agrawal et al.	370/342
*	Е	US-2003/0002454	01-2003	Lee et al.	370/328
*	F	US-2003/0016640	01-2003	Onggosanusi et al.	370/335
*	G	US-2003/0224798	12-2003	Willenegger et al.	455/450
*	Н	US-2003/0063586	04-2003	Engholm et al.	370/335
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					·
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	Р					
	Q					
	R					
	s				,	
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.